Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/992,933	KIM ET AL.
Examiner	Art Unit
TUAN A. PHAM	2618

SEARCHED				
Class	Subclass	Date	Examiner	
455	575.1	4/24/2006	РНАМ	
	575.3			
	575.4			
	575.6			
	575.8			
379	428.01	4/24/2006	РНАМ	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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- Martin				